

# SIGC18T60NC

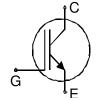
# IGBT Chip in NPT-technology

#### **FEATURES:**

- 600V NPT technology
- 100μm chip
- positive temperature coefficient
- easy paralleling

# This chip is used for:

IGBT Modules



# **Applications:**

• drives

Chip Type	V <sub>CE</sub>	I <sub>Cn</sub>	Die Size	Package	Ordering Code
SIGC18T60NC	600V	20A	4.3 x 4.3 mm <sup>2</sup>	sawn on foil	Q67050-A4139-
0100101100110	000 0	20/1	4.0 % 4.0 111111	3awii oii ioii	A001

# **MECHANICAL PARAMETER:**

Raster size	4.3 x 4.3			
Area total / active	18.49 / 14.3			
Emitter pad size	2.48 x 2.98			
Gate pad size	0.7 x 1.08			
Thickness	100	μm		
Wafer size	150	mm		
Flat position	270	deg		
Max.possible chips per wafer	796			
Passivation frontside	Photoimide			
Emitter metallization	Ilization 3200 nm Al Si 1%			
Collector metallization	1400 nm Ni Ag –system suitable for epoxy and soft solder die bonding			
Die bond	electrically conductive glue or solder			
Wire bond AI, ≤500μm				
Reject Ink Dot Size	Ø 0.65mm ; max 1.2mm			
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C			



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### **MAXIMUM RATINGS:**

Parameter	Symbol	Value	Unit
Collector-emitter voltage, $T_j$ =25 °C	V <sub>CE</sub>	600	V
DC collector current, limited by T <sub>jmax</sub>	I <sub>C</sub>	1)	А
Pulsed collector current, t <sub>p</sub> limited by T <sub>jmax</sub>	I <sub>cpuls</sub>	60	Α
Gate emitter voltage	$V_{GE}$	±20	V
Operating junction and storage temperature	$T_j$ , $T_{stg}$	-55 <b>+</b> 150	°C

<sup>1)</sup> depending on thermal properties of assembly

# **STATIC CHARACTERISTICS** (tested on chip), $T_j$ =25 °C, unless otherwise specified:

Parameter	Symbol	Conditions	Value			Unit
T drameter		Conditions	min.	typ.	max.	0
Collector-emitter breakdown voltage	$V_{(BR)CES}$	$V_{GE}=0V$ , $I_{C}=1mA$	600			
Collector-emitter saturation voltage	V <sub>CE(sat)</sub>	$V_{GE}$ =15V, $I_{C}$ =20A	1.7	2.0	2.5	V
Gate-emitter threshold voltage	$V_{\rm GE(th)}$	$I_C=0.5mA, V_{GE}=V_{CE}$	4.5	5.5	6.5	
Zero gate voltage collector current	I <sub>CES</sub>	$V_{CE}$ =600V, $V_{GE}$ =0V			1.5	μΑ
Gate-emitter leakage current	I <sub>GES</sub>	$V_{CE}=0V$ , $V_{GE}=20V$			120	nA

# **DYNAMIC CHARACTERISTICS** (tested at component):

Parameter	Symbol	Conditions	Value			Unit
raiailletei			min.	typ.	max.	Ollit
Input capacitance	Ciss	V <sub>CE</sub> =25V	-	900	-	pF
Output capacitance	Coss	$V_{GE}=0V$	-	tbd	-	
Reverse transfer capacitance	$C_{rss}$	f=1MHz	-	80	-	

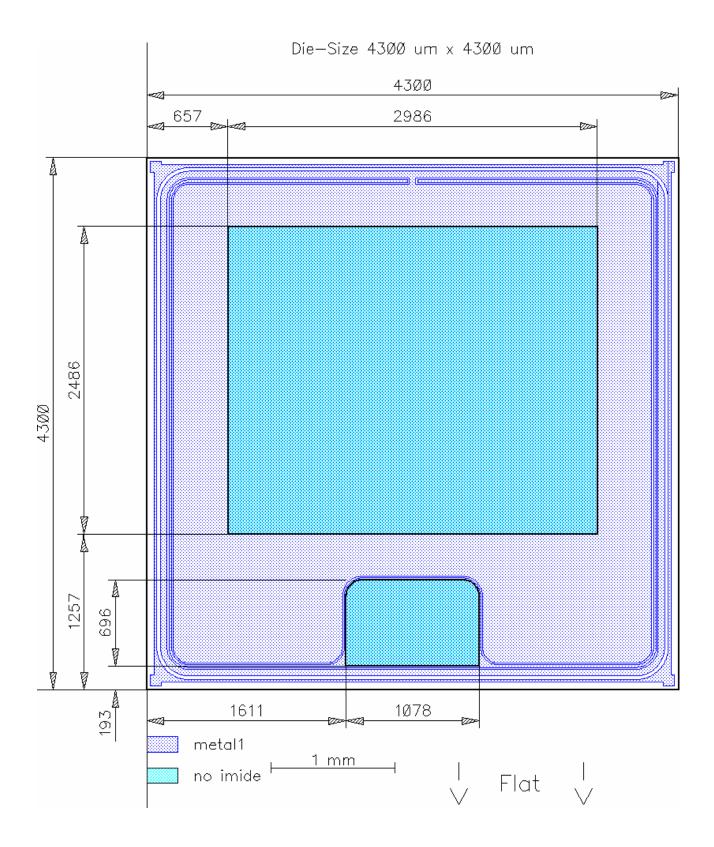
# **SWITCHING CHARACTERISTICS** (tested at component), Inductive Load:

Parameter	Symbol	Conditions 1)	Value			Unit
raiametei			min.	typ.	max.	Uilli
Turn-on delay time	$t_{d(on)}$	T <sub>j</sub> =125°C V <sub>CC</sub> =300V	-	21	-	ns
Rise time	t <sub>r</sub>	I <sub>C</sub> =20A	-	8	-	
Turn-off delay time	$t_{d(off)}$	$V_{\rm GE}$ =±15V $R_{\rm G}$ =13 $\Omega$	-	110	-	
Fall time	$t_{f}$	//G- 1032	-	25	-	

 $<sup>^{1)}</sup>$  values also influenced by parasitic L- and C- in measurement and package.



### **CHIP DRAWING:**





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#### **FURTHER ELECTRICAL CHARACTERISTICS:**

This chip data sheet refers to the device data sheet

FS 20 R06 XL4

#### **Description:**

AQL 0,65 for visual inspection according to failure catalog

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Test-Normen Villach/Prüffeld

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